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Transient strain distributions during femtosecond laser-induced deformation inside LiF and MgO single crystals

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Strain and stress dynamics inside MgO and LiF single crystals after photoexcitation by a focused femtosecond laser pulse were investigated by the observation of transient distributions of birefringence around the photoexcited region using a time-resolved polarization microscope. Both in MgO and LiF, propagation of two stress waves, which were attributed to quasi-longitudinal and quasi-transverse elastic waves, were observed, but crack propagation was observed only in LiF. Inside MgO, the observed strain distributions could be reproduced by elastic simulation, whereas inside LiF the strain distributions during crack propagation were largely different from the simulated ones; strain was widely distributed between cracks and the $\langle 110 \rangle$ regions in a stress wave, the strained region around the photoexcited region was smaller, and the strains in the $\langle 110 \rangle$ region and near the crack tips were larger than those by the simulation. The amplitudes of strain and stress in stress waves and temperature change in the photoexcited region were evaluated, and the origins of strain distribution change due to crack generation were discussed based on the differences between MgO and LiF. © 2015 AIP Publishing LLC. [<http://dx.doi.org/10.1063/1.4926614>]

I. INTRODUCTION

In crystalline solids, characteristic deformations occur under stress or shock loading.^{1–8} For example, in rock-salt crystals, such as sodium chloride (NaCl), magnesium oxide (MgO), and lithium fluoride (LiF), slips and generation of dislocations tend to occur in the $\langle 110 \rangle$ directions under a shear stress, and cleavage cracks are formed normal to $\{100\}$ planes under a tensile stress or shock.^{1,2} On the other hand, in non-crystalline solids such as glasses, deformation is often accompanied with cracks in random directions.⁹ Because the cleavage cracks can be used as rapid crystal cutting and dislocations alter the local material strength, understanding the tendency of these deformations by stresses has been one of the important issues to develop a precise material processing technique.

Generation of cracks and dislocations by stress or shock have been observed also in pulsed-laser processing, because stress or shock wave is generated as a result of ablation on the surface or fast thermal expansion inside materials.^{10–16} In the femtosecond (fs) laser bulk processing inside transparent solid materials [Fig. 1(a)], a stress wave is generated from the photoexcited region by nonlinear ionization at the laser focal region, and cracks and dislocations are generated in the specific directions inside MgO, LiF, and Al₂O₃ single crystals.^{5–7} For example, inside a MgO single crystal, of which crystal system is a rock-salt, birefringent regions of dislocations (dislocation band) appear in the $\langle 110 \rangle$ directions from the photoexcited region after focusing a fs laser pulse normal to the (001) surface [Figs. 1(b) and 1(d)].⁵

Dislocation bands appear in the $\langle 110 \rangle$ directions also inside a LiF single crystal, but cracks are formed parallel to the $\{100\}$ planes at the same photoexcitation energy as that in MgO [Figs. 1(c) and 1(d)].⁶ Such characteristic deformations inside single crystals are often explained in terms of their crystal systems and bond energies.¹ However, the mechanism of these deformations cannot be explained only by their crystal systems, because stress loading is necessary for inducing these deformations. Therefore, for understanding the mechanism of the fs laser-induced deformations inside transparent materials, it is essential to elucidate the stress dynamics after photoexcitation. If the relation between the stress dynamics and deformations is elucidated, we will be able to understand the mechanism of the stress or shock induced deformations of solids as well as find methods to control deformation by controlled stresses.

We have investigated fs laser-induced deformation and dynamics inside a MgO and LiF single crystals. Because these crystals have a simple structure (cubic) and no birefringence,¹ they are suitable for understanding the basic mechanism of laser-induced deformations as model dielectric materials. In addition, investigation of laser-induced deformation in MgO and LiF is also important for optical applications, because they have wide transmission windows in infrared, visible, and ultraviolet regions.¹⁷ In our previous study, we observed a laser-induced stress wave of characteristic shape inside MgO and LiF single crystals by a pump-probe transmission microscope, and speculated that the shape of the stress wave should be the origins of cracks and dislocations; in the stress waves, the shear stress and tensile stress were largest in the $\langle 110 \rangle$ and $\langle 100 \rangle$ directions, respectively, and they were attributed to the driving forces of the

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FIG. 1. (a) Schematic illustration of photoexcitation inside a MgO or LiF single crystal by focusing fs laser pulses. (b) and (c) Polarization microscope images of fs laser-induced modifications inside a MgO and LiF single crystal, respectively. (d) Schematic illustrations of two main deformations inside MgO and LiF single crystals.

generation of the dislocations and cracks.⁶ However, in the study, we could not elucidate the amplitudes or directions of the strain and stress that induce these structural changes. In addition, the difference in stress dynamics with and without crack generation, i.e., between LiF and MgO, has not been elucidated clearly. Elucidation of the difference in the stress dynamics between LiF and MgO is important to understand the mechanism of crack generation, because the difference could come from the crack generation.

Stress and strains inside transparent materials can be visualized through strain-induced birefringence, which has been known as a photoelastic effect.¹⁸ Because birefringence is related to the amplitude and direction of strain and can be analyzed by the polarization change of a probe light,^{18,19} it is possible to visualize transient strain distributions after

photoexcitation inside transparent materials by polarization detection. In this study, to clarify the strain and stress distributions and the difference in strain dynamics between MgO and LiF, we developed a pump-probe polarization microscope²⁰ and observed transient distributions of birefringence inside MgO and LiF single crystals after photoexcitation by a focused fs laser pulse. We found that the observed strain dynamics could be reproduced by the elastic simulation in MgO, in which cracks were not generated, whereas the observed strain dynamics were quite different from the simulated dynamics in LiF, in which cracks were generated. Based on the observation, we evaluated the amplitudes of strain and stress by laser induced stress wave and temperature increase in the photoexcitation, and discussed the mechanism of dislocation and crack generation and the origins of differences in the strain dynamics between MgO and LiF.

II. EXPERIMENTAL AND SIMULATION

A. Pump-probe polarization microscope

A schematic illustration of the pump-probe polarization microscope is shown in Fig. 2(a). A 120 fs laser pulse of 800 nm wavelength (mode-locked Ti-sapphire laser with a regenerative amplifier, Mira-Legend; Coherent Inc.) was divided into two by a beam splitter. One of the split pulses was used as a pump pulse, and the other was passed through a BBO (β -BaB₂O₄) crystal to generate the second harmonic (wavelength: 400 nm) and used as a probe pulse. The pump pulse was focused inside a MgO or LiF single crystal ($10 \times 10 \times 1.0$ mm³) with a $50\times$ objective lens (Nikon, LU Plan $50\times$, N.A. = 0.8) to induce nonlinear-photoexcitation inside the crystal. The incident of the pump pulse was normal to the (001) surface of the crystal and the depth of the focus was about 0.1 mm from the surface of the sample. Because the photoexcited volume depends on the depth of the focus due to a spherical aberration, the depth of the focus was the same through the experiment. The probe pulse was

FIG. 2. (a) Optical setup of a pump-probe polarization microscope. BS: a beam splitter, QWP1, QWP2: quarter waveplates, DM: dichroic mirror, OL: $50\times$ objective lens, Lens: a convex lens of $f = 300$ mm. The analyzer was removed in observation of transmission images. (b) Schematic illustration of the principle for the measurement of birefringence by the optical setup of (a). The probe pulse before the crystal is circularly polarized and the intensity is I_0 . The probe light just before detection is linearly polarized and the intensity is I_{out} . (c) Ratios of transient images and reference images obtained under different χ and θ_a by the pump-probe measurement of (a). These were the images at 3 ns after irradiation with a focused fs laser pulse of $2 \mu\text{J}$ inside a LiF single crystal. (d) Plot of I_{tr}/I_{ref} at a single pixel in the images of (c) against $\chi + \theta_a$ and fitting with Eq. (3).

optically delayed by an optical delay line and converted to a circularly polarized light by a polarizer and quarter waveplate (QWP1). The zero-delay was determined by monitoring the optical Kerr effect by the pump pulse (the detail is described in the supplementary material²¹). The probe pulse was transmitted through the photoexcited region inside the crystal from the opposite direction of the pump pulse. The transmitted probe pulse was magnified by the objective lens, and the transmission image around the photoexcited region was focused on a charge coupled device (CCD) camera by a convex lens ($f = 300$ mm). Before being detected by the CCD, the probe pulse was reflected by a dichroic mirror (DM) and transmitted through a quarter waveplate (QWP2) and analyzer.

A probe image by a single photoexcitation was obtained by a single image acquisition by the CCD camera, and four images were averaged to obtain the intensity distribution of the probe pulse. In a single data acquisition, two probe images, before and after photoexcitation, were obtained. We call probe images before and after photoexcitation “reference image” and “transient image,” respectively. Every single data acquisition, the crystal was moved by $100\ \mu\text{m}$ perpendicular to the optical axis of the pump pulse to avoid the influence by the previous photoexcitation. For analysis of transient birefringence, the intensity distributions of the probe pulse were obtained at various orientations of the QWP2 (χ) and analyzer (θ_a), and the birefringence distributions were obtained by analyzing the relation between the intensity distribution and χ . The method for the analysis is explained in Subsection II B.

B. Analysis of birefringence

The analysis of the birefringence is based on the calculation of polarization change of the probe beam in the pump-probe polarization microscope. For the analysis, the polarization change was calculated by the Jones calculus.²² The polarization change of the probe pulse is illustrated schematically in Fig. 2(b). Because the probe pulse before transmitting through the crystal is circularly polarized, the probe pulse before the sample is expressed by $(I_0/2)^{1/2} (1, i)^T$, where I_0 and τ denote the intensity of the probe pulse and transposition for the vector, respectively. The polarization of the probe pulse is altered at three stages; at transmission through the sample, reflection on the DM and transmission through the QWP2. When the angle of QWP2 is χ , the retardance by the DM is δ_{DM} , the azimuth and retardance of the birefringence of the sample are θ_S , and δ_S , respectively, and the angle of the analyzer is θ_a , the light intensity after the analyzer (I_{out}) can be expressed by

$$I_{out}(\chi; \theta_a; \theta_S, \delta_S) = \frac{1}{2} I_0 \left| \begin{pmatrix} \cos^2 \theta_a & \sin \theta_a \cos \theta_a \\ \sin \theta_a \cos \theta_a & \sin^2 \theta_a \end{pmatrix} \right|^2 \times M(\chi, \pi/2) M(0^\circ, \delta_{DM}) M(\theta_S, \delta_S) \begin{pmatrix} 1 \\ i \end{pmatrix} \quad (1)$$

where $M(\alpha, \delta)$ is the Jones Matrix which is defined by

$$M(\alpha, \delta) = \begin{pmatrix} \cos \alpha & \sin \alpha \\ -\sin \alpha & \cos \alpha \end{pmatrix} \begin{pmatrix} 1 & 0 \\ 0 & e^{i\delta} \end{pmatrix} \begin{pmatrix} \cos \alpha & -\sin \alpha \\ \sin \alpha & \cos \alpha \end{pmatrix}, \quad (2)$$

where α and δ are the azimuth of the slow-axis and retardance of the birefringence. For example, δ of a quarter waveplate is $\pi/2$, which corresponds to a quarter of a wavelength. In this experiment, the DM was aligned so that the angle of the birefringence was parallel to the x axis of this system ($\alpha_{DM} = 0^\circ$). The retardance by the DM, δ_{DM} , was determined as $\delta_{DM} = -0.078\pi$ independently.

The intensity of a transient image (I_{tr}) is given by $I_{tr} = I_{out}(\chi, \theta_a; \theta_S, \delta_S)$, because birefringence appears in a crystal by photoexcitation. The intensity of a reference image (I_{ref}) is given by $I_{out}(\chi, \theta_a; 0^\circ, 0)$, because there is no birefringence in a crystal before photoexcitation. To cancel out I_0 , we calculated the ratio between the intensities of the intensities of transient and reference images, $I_{tr}/I_{ref} = R(\chi, \theta_a; \theta_S, \delta_S)$. $R(\chi, \theta_a; \theta_S, \delta_S)$ can be expressed by

$$R(\chi, \theta_a; \theta_S, \delta_S) = I_{out}(\chi, \theta_a; \theta_S, \delta_S) / I_{out}(\chi, \theta_a; 0^\circ, 0). \quad (3)$$

In the experiment, the reference image and transient image were obtained as a function of χ and $\theta_a = 0^\circ$ or 90° , and the ratio between the transient image [$I_{tr}(\chi, \theta_a)$] and reference image [$I_{ref}(\chi, \theta_a)$] was calculated as shown in Fig. 2(c). To obtain the birefringence at one pixel on a CCD, $I_{tr}(\chi, \theta_a)/I_{ref}(\chi, \theta_a)$ was fitted by nonlinear least squared method with a fitting function of Eq. (3). The fitting parameters are θ_S and δ_S . The example of a plot of $I_{tr}(\chi, \theta_a)/I_{ref}(\chi, \theta_a)$ against $\chi + \theta_a$ and fitting with Eq. (3) are shown in Fig. 2(d).

C. Simulation of a fs laser-induced strain dynamics

The transient strain distributions inside MgO and LiF single crystals were simulated based on the elastic dynamics.²³ We assumed that the main origin of a fs laser-induced stress wave was a thermal stress in the photoexcited region and the thermal stress was generated instantaneously after the photoexcitation. The distribution of the temperature change in the photoexcited region [$\Delta T(x, y, z)$] was expressed by a Gaussian function as follows:

$$\Delta T(x, y, z) = \Delta T_{\max} * \exp \left[-\frac{x^2 + y^2}{(w_{th}/2)^2} - \frac{z^2}{(l_z/2)^2} \right], \quad (4)$$

where $\Delta T_{\max}$ is the temperature change at the peak due to photoexcitation, x , y , and z are the coordinates in the material, w_{th} and l_z are, respectively, the width and length of the heated region. Here, z is the propagation direction of a fs laser pulse. In this study, a fs laser pulse was focused normal to the (001) plane of a MgO and LiF single crystal, and we defined x , y , and z as [100], [010], and [001] of the cubic system, respectively. According to the elastic dynamics, the temporal evolution of displacements in a material can be calculated by the following equation of motion:

$$\rho \frac{\partial^2 \mathbf{u}(x, y, z; t)}{\partial t^2} = \nabla \cdot [\mathbf{P}(x, y, z; t) - \mathbf{P}^{(thermal)}(x, y, z)], \quad (5)$$

where t is the time after the photoexcitation, ρ is the density of the material, $\mathbf{u}(x, y, z; t)$ is the displacement vector at t , $\mathbf{P}(x, y, z; t)$ is the stress tensor due to the displacement, and

$\mathbf{P}^{(thermal)}(x, y, z)$ is the thermal stress tensor due to the temperature change. According to the Hook's law, the components of $\mathbf{P}(x, y, z; t)$ in a crystal of cubic system can be expressed by

$$P_{ii} = C_{11}S_{ii} + C_{23}(S_{jj} + S_{kk}) \quad (i, j, k = x, y, z; i \neq j \neq k \neq i), \quad (6)$$

$$P_{ij} = 2C_{44}S_{ij} \quad (i \neq j), \quad (7)$$

where P_{ij} and S_{ij} are the components of the stress and strain tensor, respectively, and C_{ij} are the components in the elastic tensor of the material. The strain tensor, $\mathbf{S}(x, y, z; t)$, was calculated by

$$\mathbf{S}(x, y, z; t) = \frac{1}{2} [\nabla \mathbf{u} + (\nabla \mathbf{u})^T]. \quad (8)$$

The thermal stress tensor in a crystal of cubic system can be expressed by

$$\mathbf{P}_{ij}^{(thermal)}(x, y, z) = \beta \Delta T(x, y, z)(C_{11} + 2C) \delta_{ij}, \quad (9)$$

where β is the thermal expansion coefficient of the material and δ_{ij} is the Kronecker delta. Equation (5) with Eqs. (4) and (6)–(9) were calculated numerically to obtain the distribution of the displacement in a crystal [$\mathbf{u}(x, y, z; t)$] after the generation of thermal stress by photoexcitation. The densities, thermal expansion coefficients, and elastic constants of MgO and LiF single crystals for the numerical calculation were listed in Table I.^{24–27}

D. Calculation of strain and stress

Strain and stress distributions were calculated by an observed distribution of birefringence, of which retardance and azimuth are, respectively, δ_S and θ_S , using the photoelastic constants of a material. The relations between strain and strain-induced birefringence in a cubic system are given by^{18,19}

$$|S_{xx} - S_{yy}| = \delta_S \frac{\lambda_{probe}}{n_0^3 \pi l} \left| \frac{\cos 2\theta_S}{p_{11} - p_{12}} \right|, \quad (10)$$

$$2|S_{xy}| = \delta_S \frac{\lambda_{probe}}{n_0^3 \pi l} \left| \frac{\sin 2\theta_S}{2p_{44}} \right|, \quad (11)$$

where S_{xx} , S_{yy} , and S_{xy} are the strain tensor components, n_0 is the refractive index of the material, p_{11} , p_{12} , and p_{44} are the photoelastic constants of the material, λ_{probe} (=400 nm in this study) is the wavelength of a probe pulse, and l is the length of the birefringence region in the probe beam axis.

TABLE I. Properties of MgO and LiF single crystals used in this study. Densities (ρ/gcm^{-3}),^{24,25} thermal expansion coefficient (β/K^{-1}),^{26,27} elastic constants (C_{ij}/GPa),^{24,25} refractive indices (n_0),^{29,30} photoelastic constants (p_{ij}),^{29,31} and surface energies (γ_B/Jm^{-2}) of MgO and LiF single crystals.³²

	ρ	β	C_{11}	C_{23}	C_{44}	n_0	$p_{11}-p_{12}$	p_{44}	γ_B
MgO	3.58	1.1×10^{-5}	297	95	156	1.7	-0.25	-0.10	1.2
LiF	2.64	3.3×10^{-5}	111	42	63	1.4	-0.10	-0.043	0.34

Here, we assumed that the strains in the z direction (parallel to the propagation of a pump pulse) are negligible. Using Eqs. (10) and (11), the principal strain can be expressed by

$$|S_r - S_\theta| = \delta_S \frac{\lambda_{probe}}{n_0^3 \pi l} \left| \left(\frac{\cos 2\theta_S}{p_{11} - p_{12}} \right)^2 + \left(\frac{\sin 2\theta_S}{2p_{44}} \right)^2 \right|^{0.5}, \quad (12)$$

where S_r and S_θ are the principal strains. In an optically isotropic material, $|p_{11}-p_{12}|$ is equal to $|2p_{44}|$ (for example, in a silica glass, $p_{11}-p_{12} = -0.145$ and $p_{44} = -0.073$),²⁸ so $|S_r - S_\theta|$ is independent on θ_S . Because the stress and strain were related by the elastic tensor of the material (Eqs. (6) and (7)), the principal stress is given by

$$|P_r - P_\theta| = \{[(C_{11} - C_{23}) \cos 2\theta]^2 + [2C_{44} \sin 2\theta]^2\}^{0.5} |S_r - S_\theta|. \quad (13)$$

The refractive indices, photoelastic constants and elastic constants of MgO and LiF for the calculation are listed in Table I.^{29–32}

III. RESULTS AND DISCUSSION

A. Transient transmission images inside MgO and LiF single crystals

First, we observed time-resolved transmission images of probe pulses to see what had happened inside MgO and LiF crystals after irradiation with a focused fs laser pulse. In this observation, transmission images were obtained by the optical setup of Fig. 2(a) without an analyzer. Figure 3(a) shows the transmission images at various time delays after photoexcitation inside a MgO crystal by a fs laser pulse of 2 μJ . After the photoexcitation, a squircle-shaped stress wave was generated around the photoexcited region at the center. In our previous study, the generation of the stress wave was attributed to the sudden generation of thermal stress around the photoexcited region within the acoustic relaxation time.^{7,20} The shape of the stress wave is the result of the direction-dependent velocity of the elastic wave due to the anisotropic elastic tensor of a MgO single crystal (Table I). The observed velocities of the stress wave were about 9.3 $\mu\text{m}/\text{ns}$ in the $\langle 100 \rangle$ and 10.1 $\mu\text{m}/\text{ns}$ in the $\langle 110 \rangle$. According to the elastic dynamics,³³ the phase velocities of quasi-longitudinal elastic waves inside a MgO single crystal are calculated to be 9.1 $\mu\text{m}/\text{ns}$ in the $\langle 100 \rangle$ and 9.9 $\mu\text{m}/\text{ns}$ in the $\langle 110 \rangle$ (Table II). The theoretical velocities were close to the observed ones.

Inside a LiF single crystal (Fig. 3(b)), the propagation of cracks in the $\langle 100 \rangle$ directions as well as squircle-shaped stress wave were observed at the same time. The cracks were always inside the stress wave, and the stress wave propagated more slowly than in a MgO single crystal. The propagation velocities of the stress wave were about 6.9 $\mu\text{m}/\text{ns}$ in the $\langle 100 \rangle$ and 7.6 $\mu\text{m}/\text{ns}$ in the $\langle 110 \rangle$, which were similar to the phase velocities of the quasi-longitudinal elastic waves calculated based on the elastic dynamics (6.5 $\mu\text{m}/\text{ns}$ and 7.3 $\mu\text{m}/\text{ns}$, respectively; Table II).

The time-resolved observations suggest that the characteristic shapes of the stress waves had concentrated shear

FIG. 3. Time-resolved transmission images after photoexcitation by a fs laser pulse focused inside a (a) MgO and (b) LiF single crystal. The scale bar and the orientation of the crystal were the same in (a) and (b).

stress or tensile stress in the specific regions and they could be the driving forces of the generation of the dislocation bands and cracks. However, the transmission images cannot give us any knowledge on the directions or relative amplitude of the stress and strain. Therefore, the observation of transient stress distributions is necessary for elucidating the mechanism of dislocation and crack generation.

B. Strain dynamics in MgO

1. Transient birefringence images inside MgO

Figures 4(a) and 4(b) show the distributions of transient birefringence inside MgO after photoexcitation by a focused fs laser pulse of 1 μJ. Two propagating birefringent regions were observed; one is a squircle-shaped stress wave, which had been observed also in the transmission image (Fig. 3(a)), and the other propagated more slowly than the squircle-shaped stress wave, which could not be observed clearly in the transmission image. In our previous study, both these propagating regions were attributed to stress waves, and we called them “primary stress wave” and “secondary stress wave,” respectively. The secondary stress waves propagated mainly in the $\langle 100 \rangle$ direction and the velocity was about 6.4 μm/ns, which was close to the velocity in $\langle 100 \rangle$ of the quasi-transversal elastic wave in MgO ($v_{\langle 100 \rangle}^{(t)} = 6.6 \mu\text{m/ns}$

TABLE II. Phase velocities of elastic waves ($v/\mu\text{m ns}^{-1}$) inside MgO and LiF crystals calculated based on the elastic dynamics. $v_{\langle 100 \rangle}^{(l)}$ and $v_{\langle 110 \rangle}^{(l)}$ are the velocities of quasi-longitudinal elastic waves in the $\langle 100 \rangle$ and $\langle 110 \rangle$, respectively, and $v_{\langle 100 \rangle}^{(t)}$ is that of a quasi-transverse elastic wave in the $\langle 100 \rangle$. They were calculated by the theoretically derived equations: $v_{\langle 100 \rangle}^{(l)} = \sqrt{C_{11}/\rho}$, $v_{\langle 110 \rangle}^{(l)} = \sqrt{(C_{11} + C_{23} + 2C_{44})/(2\rho)}$, $v_{\langle 100 \rangle}^{(t)} = \sqrt{C_{44}/\rho}$ based on the elastic dynamics.³³

	$v_{\langle 100 \rangle}^{(l)}$	$v_{\langle 110 \rangle}^{(l)}$	$v_{\langle 100 \rangle}^{(t)}$
MgO	9.1	9.9	6.6
LiF	6.5	7.3	4.9

FIG. 4. (a) Retardance and (b) slow-axis azimuth distributions of transient birefringence at various time delays after photoexcitation by a fs laser pulse focused inside a MgO single crystal. The pulse energy was 1 μJ. The colored semicircle indicates the relation between color and azimuth. (c) and (d) Slow-axis azimuth distributions at 3000 ps and plots of retardance along $\langle 110 \rangle$ and $\langle 100 \rangle$ lines (broken lines in the azimuth images), respectively. “PW” and “SW” mean “primary stress wave” and “secondary stress wave,” respectively. The angles written in the plots indicate the azimuth at the retardance peaks. (e) Transient strain distributions obtained by the transient distributions of birefringence in (a) and (b).

in Table II). On the other hand, the observed velocity of the primary stress wave was similar to that of the quasi-longitudinal elastic wave in MgO as described in Subsection III A. Because the displacements in quasi-longitudinal and quasi-transversal elastic waves are mainly parallel and perpendicular to the propagation directions, respectively, the displacement in the primary wave should be mainly parallel to the propagation direction, while that in the secondary wave should be mainly perpendicular to the propagation direction.

Figures 4(c) and 4(d) show the distributions of the slow-axis of birefringence at 3000 ps and the plots of the retardance along $\langle 110 \rangle$ and $\langle 100 \rangle$ lines (broken lines in Figs. 4(c) and 4(d), respectively). Along the $\langle 110 \rangle$ line (Fig. 4(c)), the slow-axis in the front part of the primary stress wave was parallel to the propagation direction ($=45^\circ$), while that in the back part was perpendicular to the propagation direction ($=-45^\circ$). Also along the $\langle 100 \rangle$ line (Fig. 4(d)), the slow-axes in the front part and back part of the primary stress wave were, respectively, parallel ($=0^\circ$) and perpendicular ($=90^\circ$) to the propagation direction. Because the primary stress wave had been attributed to a quasi-longitudinal wave,

of which displacement should be mainly parallel to the propagation direction, the observed slow-axis distribution in the primary stress wave means that the front part of the stress wave was compressed in the propagation direction, whereas the back part was expanded in the propagation direction. On the other hand, the slow-axis in the secondary stress waves was parallel to the propagation direction (0° along the $\langle 100 \rangle$ line) (Fig. 4(d)). Because the secondary stress wave had been attributed to a quasi-transverse wave, of which displacement should be mainly perpendicular to the propagation direction, the slow-axis in the secondary stress wave means that the crystal in the secondary stress wave should have been stretched perpendicular to the propagation direction.

The birefringence around the photoexcited region was much larger than those in any other region and did not change in the observation time range. The quasi-static birefringence around the photoexcited region should be due to the thermal stress, because the thermal stress is much larger than those in stress waves as shown by an elastic simulation shown in Subsection III B 2 and the thermal diffusion would have occurred in a longer time range (after 100 ns).^{13,34}

Under the assumption that the origin of the birefringence should be anisotropic strain in a solid, the distribution of the difference between the principal strains ($|S_r - S_\theta|$) can be obtained using the relation between strain and birefringence (Eq. (12)). The calculated distributions of $|S_r - S_\theta|$ from Figs. 4(a) and 4(b) were shown in Fig. 4(e). In the calculation, we used the material properties in Table I and $l = 18 \mu\text{m}$, which was the observed length of the structural change in the laser propagation axis. The $|S_r - S_\theta|$ distributions in the primary stress wave had maximum around the $\langle 110 \rangle$ directions (Fig. 4(e)), whereas the observed retardance in the primary stress wave was almost homogeneous (Fig. 4(a)). This difference comes from the anisotropy of the photoelastic tensor of a MgO crystal, i.e., the strain-induced birefringence is larger in the $\langle 100 \rangle$ direction than in the $\langle 110 \rangle$ direction ($|p_{11} - p_{12}| > |2p_{44}|$). The temporal evolution of $|S_r - S_\theta|$ in the stress wave will be described in detail in Subsection III B 3.

2. Simulation of the transient strain distributions inside MgO

The thermo-elastic simulation helps us to understand deformation in the fs laser-induced stress wave. The $|S_r - S_\theta|$ distributions at 1000, 2000, and 3000 ps were shown in Fig. 5(a) to compare with the observed distributions of birefringence (Fig. 4(e)). The parameters for the simulation were $\Delta T = 100 \text{ K}$, $w_{\text{th}} = 1 \mu\text{m}$, and $l_z = 20 \mu\text{m}$, which generates a stress wave of the same width as the observed ones. The $|S_r - S_\theta|$ distributions by the simulation, the shape of the stress waves, and the range of the thermal stressed region were almost the same as those by the observation. The direction of the principal strain at 3000 ps shown in Fig. 5(b) was almost same as the observed slow-axis distribution of birefringence in Fig. 4(b). Figures 5(c) and 5(d) show the plot of $|S_r - S_\theta|$ along $\langle 110 \rangle$ and $\langle 100 \rangle$ lines at 3000 ps (the lines are drawn in Fig. 5(a)). The $|S_r - S_\theta|$ distributions along $\langle 110 \rangle$ and $\langle 100 \rangle$ lines are similar to the observed retardance distributions shown in Figs. 4(c) and 4(d). Figures 5(e) and 5(f) shows the

FIG. 5. (a) $|S_r - S_\theta|$ distributions at various times inside MgO calculated based on thermoelastic simulation. $\Delta T_{\text{max}} = 100 \text{ K}$, $w_{\text{th}} = 1.0 \mu\text{m}$, and $l_z = 18 \mu\text{m}$. (b) Distribution of the direction of the principal strains at 3000 ps, in which the direction is represented by color. The relation between the direction and color is shown by the colored semicircle. (c) and (d) Plots of the $|S_r - S_\theta|$ at 3000 ps along $\langle 110 \rangle$ and $\langle 100 \rangle$ lines drawn in (a), respectively. (e)–(g) Lattice deformations at 3000 ps in the areas shown in (b).

simulated lattice deformations at 3000 ps around the primary stress wave. These lattice deformations show that the front part in the primary stress wave was compressed in the propagation direction, while the latter part was expanded in the propagation direction. On the other hand, in the simulated lattice deformation around the secondary stress wave shown in Fig. 5(g), the expansion perpendicular to the propagation direction predominates in the secondary stress wave. These deformations are consistent to the assignments of the primary and secondary stress waves to quasi-longitudinal and quasi-transverse waves, respectively.

3. Amplitude of principal strain and stress in MgO

The amplitudes of $|S_r - S_\theta|$ (difference of principal strains) and $|P_r - P_\theta|$ (difference of principal stresses) in stress waves were calculated from the observed birefringence using Eqs. (12) and (13) and the observed length of the modified region in the beam propagation direction; $l = 18 \mu\text{m}$ for $1 \mu\text{J}$ and $l = 24 \mu\text{m}$ for $2 \mu\text{J}$. Here, we focused the $|S_r - S_\theta|$ and $|P_r - P_\theta|$ at the peaks in the primary and secondary stress waves along the $\langle 100 \rangle$ and $\langle 110 \rangle$ lines. They were denoted by $|\Delta S^{(\Gamma)}_\alpha|$ and $|\Delta P^{(\Gamma)}_\alpha|$ of which positions are shown in Fig. 6(a). In these notations, Γ indicates the mode of the stress waves (i.e., $\Gamma = p$ and $\Gamma = s$ for primary and secondary stress waves, respectively) and α indicates the direction of the stressed region from the photoexcited region (i.e., $\alpha = \langle 100 \rangle$ means the stress on the $\langle 100 \rangle$ line.). The temporal evolutions of the $|\Delta S^{(\Gamma)}_\alpha|$ and

FIG. 6. (a) The positions of $|\Delta S^{(p)}_{\langle 110 \rangle}|$, $|\Delta S^{(p)}_{\langle 100 \rangle}|$, and $|\Delta S^{(s)}_{\langle 100 \rangle}|$. (b)–(d) The differences of principal strains and stresses inside MgO plotted against the time delays. Solid line and dotted line in (b) and (d) are $|S_r - S_\theta|$ by the simulation of $\Delta T_{\max} = 2700$ K, $w_{\text{th}} = 2 \mu\text{m}$ and that of $\Delta T_{\max} = 2300$ K and $w_{\text{th}} = 1.1 \mu\text{m}$, respectively, whereas those in (c) are $|S_r - S_\theta|$ by the simulation of $\Delta T_{\max} = 1900$ K and that of $\Delta T_{\max} = 1700$ K, respectively.

$|\Delta P^{(T)}_\alpha|$ at the peak in the stress waves were shown in Figs. 6(b) and 6(c). The strain and stress amplitudes were in the ranges of $0.1 \times 10^{-2} - 1 \times 10^{-2}$ and $0.25 - 2.5$ GPa, respectively, and those at pulse energy of $2 \mu\text{J}$ were about twice larger than those of $1 \mu\text{J}$. The stress range on the $\langle 110 \rangle$ line was about 1.5 times larger than those on $\langle 100 \rangle$, which is because of anisotropic stress tensor in MgO; according to Eq. (13), $|\Delta P_{\langle 110 \rangle}| = 2 * C_{44} * |\Delta S_{\langle 110 \rangle}| = 312 \text{ (GPa)} * |\Delta S_{\langle 110 \rangle}|$, while $|\Delta P_{\langle 100 \rangle}| = (C_{11} - C_{23}) * |\Delta S_{\langle 100 \rangle}| = 202 \text{ (GPa)} * |\Delta S_{\langle 100 \rangle}|$.

We found that there were small differences in the relative amplitudes of $|S_r - S_\theta|$ between the observation and simulation. To compare the differences, the ratios of $|\Delta S^{(p)}_{\langle 110 \rangle}|$ and $|\Delta S^{(s)}_{\langle 100 \rangle}|$ to $|\Delta S^{(p)}_{\langle 100 \rangle}|$ were listed in Table III. The average ratios of $|\Delta S^{(s)}_{\langle 100 \rangle}|$ to $|\Delta S^{(p)}_{\langle 100 \rangle}|$ in 2000–6000 ps were about 0.84 in the experiment, which were similar to that in the simulation. On the other hand, The average ratios of $|\Delta S^{(p)}_{\langle 110 \rangle}|$ to $|\Delta S^{(p)}_{\langle 100 \rangle}|$ in 2000–6000 ps were 1.23 at $1 \mu\text{J}$ and 1.34 at $2 \mu\text{J}$, which were 20%–25% smaller than that in the simulation ($|\Delta S^{(p)}_{\langle 110 \rangle}| / |\Delta S^{(p)}_{\langle 100 \rangle}| \sim 1.65$). These differences may come from the generation of dislocations in the $\langle 110 \rangle$ directions, because the dislocation bands have been observed in $\langle 110 \rangle$ after fs laser irradiation in MgO (Ref. 5) and it is possible that the energy of the stress wave in $\langle 110 \rangle$ might have lost by generation of dislocations.

TABLE III. Ratios of $|\Delta S^{(s)}_{\langle 100 \rangle}|$ and $|S^{(p)}_{\langle 110 \rangle}|$ to $|S^{(p)}_{\langle 100 \rangle}|$ inside MgO by the observation and elastic simulation.

	$ \Delta S^{(s)}_{\langle 100 \rangle} / S^{(p)}_{\langle 100 \rangle} $		$ \Delta S^{(p)}_{\langle 110 \rangle} / \Delta S^{(p)}_{\langle 100 \rangle} $	
	1 μJ	2 μJ	1 μJ	2 μJ
Observation	0.84 (± 0.06)	0.84 (± 0.05)	1.23 (± 0.10)	1.34 (± 0.20)
Simulation	0.85	0.77	1.65	

These differences affect the estimation of the initial temperature change in the photoexcited region ($\Delta T_{\max}$) from the comparison of the evaluated strains with those by the simulation. When the temporal evolutions of $|\Delta S^{(p)}_{\langle 100 \rangle}|$ and $|\Delta S^{(s)}_{\langle 100 \rangle}|$ by the experiment were fitted by the simulated strains, the initial temperature changes to fit the experimental values were $\Delta T_{\max} = 2700$ K for $2 \mu\text{J}$ and $\Delta T_{\max} = 2300$ K for $1 \mu\text{J}$ (solid and dotted lines in Figs. 6(b) and 6(d)). On the other hand, the temperature increases for the simulation to fit the temporal evolution of $|\Delta S^{(p)}_{\langle 110 \rangle}|$ were $\Delta T_{\max} = 1900$ K for $2 \mu\text{J}$ and $\Delta T_{\max} = 1700$ K for $1 \mu\text{J}$ (solid and dotted lines in Fig. 6(c)). Using these temperature changes ($\Delta T_{\max} = 2700$ K and 2300 K) and Eq. (9), the stresses at the photoexcited region are estimated to be 14 GPa for $2 \mu\text{J}$ and 12 GPa for $1 \mu\text{J}$.

C. Strain dynamics in LiF

1. Transient birefringence images inside LiF

Figures 7(a) and 7(b) show the distributions of transient birefringence inside LiF after photoexcitation by a focused fs laser pulse of $1 \mu\text{J}$. A squircle-shaped birefringent wave (primary stress wave) propagated as observed in the transmission images (Fig. 3(b)). The distribution of birefringence inside the primary stress wave was completely different from that in MgO. Whereas the birefringent regions due to the secondary stress waves in MgO were separated from the primary stress wave (Figs. 4(a) and 4(b)), the birefringent region inside the primary stress wave in LiF was distributed from the cracks to the $\langle 110 \rangle$ regions in the primary stress wave (Figs. 7(a) and 7(b)). The peaks in the birefringent region inside the primary stress wave were located at the tips of cracks until the crack propagation stopped. After the crack propagation stopped (6000 ps in Fig. 7(b)), the birefringent regions inside the primary stress wave propagated away from the cracks at about $4.2 \mu\text{m/ns}$ in the $\langle 100 \rangle$ direction. This propagation velocity is

FIG. 7. (a) Retardance and (b) slow-axis azimuth distributions of transient birefringence inside a LiF single crystal at various time delays after photoexcitation by a focused fs laser pulse. The relation between color in (b) and azimuth is the same as that in Fig. 4. (c) and (d) Slow-axis azimuth distributions and plots of retardance along $\langle 110 \rangle$ and $\langle 100 \rangle$ lines, respectively. PW in the plot means “primary stress wave.” (e) Transient strain distributions obtained from the transient birefringence images in (a) and (b).

about 85% of the phase velocity of quasi-transverse elastic wave, $4.9 \mu\text{m/ns}$ ($v_{\langle 100 \rangle}^{(t)}$ in Table II). Because the shape of the birefringent region at 6000 ps was similar to the strained region in the quasi-transverse elastic wave in LiF as described in Subsection III C 2, the birefringent peak near the crack tip should be attributed to the quasi-transverse elastic wave.

Figures 7(c) and 7(d) show the slow-axis azimuth distributions at 3000 ps and the plots of the retardance along $\langle 110 \rangle$ and $\langle 100 \rangle$ lines, respectively. As observed in MgO, the slow-axis in the primary stress wave (PW) was parallel to the propagation direction (0° in $\langle 100 \rangle$ and 45° in $\langle 110 \rangle$). Therefore, the dominant deformation in the primary stress wave in LiF was compression in the propagation direction. However, birefringence was not observed in the back part of the stress wave, although it was observed clearly in MgO (Figs. 4(c) and 4(d)). The absence of the strain in the back part of the stress wave in LiF might be due to the crack generation.

The slow axis at the birefringence peak near the crack tip was also parallel to the propagation direction. Because the birefringence peak was attributed to the quasi-transverse elastic wave, the displacement perpendicular to the propagation direction should be dominant near the crack tip. According to the slow axis parallel to the propagation

direction, the expansion perpendicular to the crack should have occurred near the crack tip as predicted by the elastic simulation in MgO (Fig. 5(g)). This displacement direction suggests that the crack propagation in LiF should be mode I, separation of the crack walls under tensile stresses.⁸

Figure 7(e) shows the distributions of difference between principal strains ($|S_r - S_\theta|$) calculated by birefringence distribution, Eq. (12), photoelastic constants of LiF (Table I) and observed length of the modified region in the beam propagation direction; $l = 15 \mu\text{m}$ for $1 \mu\text{J}$ and $l = 20 \mu\text{m}$ for $2 \mu\text{J}$. Because the ratio of $|p_{11} - p_{23}|$ to $|2p_{44}|$ is about 1.5 in LiF, the principal strain in $\langle 110 \rangle$ becomes larger than that in $\langle 100 \rangle$ compared with the birefringence distribution (Fig. 7(a)). The distributions of $|S_r - S_\theta|$ show that the strain was concentrated in the $\langle 110 \rangle$ direction and a strained region of crossed pattern appeared in the $\langle 110 \rangle$ directions from the photoexcited region. The $|S_r - S_\theta|$ around the photoexcited region was much smaller than that in MgO. The small $|S_r - S_\theta|$ suggests that the thermal stress in the photoexcited region had been relaxed due to crack generation.

2. Simulation of the transient strain distributions inside LiF

The $|S_r - S_\theta|$ distributions were simulated by elastic dynamics and shown in Fig. 8 (amplitude in 8(a) and direction in 8(b)). The parameters for the simulation were $\Delta T = 100 \text{ K}$, $w_{\text{th}} = 2.0 \mu\text{m}$, and $l_z = 20 \mu\text{m}$. While the observed birefringence distribution at 6000 ps (Fig. 7(b)), at which the crack propagation had stopped, is similar to the $|S_r - S_\theta|$ distribution by the simulation (6000 ps in Fig. 8(b)), there are several apparent differences in $|S_r - S_\theta|$ between the observation (Figs. 7(a) and 7(b)) and simulation (Figs. 8(a) and 8(b)) until the crack propagation stops. The first difference is the strain distribution inside the primary stress wave. In the observation, the strain was distributed between the cracks and the $\langle 110 \rangle$ regions of the primary stress wave, whereas the strains inside the primary stress wave were distributed around the $\langle 100 \rangle$ lines as a secondary stress wave in the simulation. The second difference is the strained region of a cross pattern in the observation (Fig. 7(d)), which did not appear in the simulation. The direction of the principal strain in the cross pattern was parallel to the $\langle 110 \rangle$ lines, which means that the crystal had been compressed in the $\langle 110 \rangle$ directions in the strain region of a cross pattern. Therefore, the strained region of the cross pattern might be attributed to dislocations, which can be generated by compression in the $\langle 110 \rangle$ in rock-salt single crystals (Fig. 1(d)) and cannot be explained by linear elastic dynamics. The third difference is the range of strain around the photoexcited region. The strained region around the photoexcited region in the observation was much smaller than that in the simulation. Because the strain around the photoexcited region in the simulation is due to the thermal stress, the small strained region in the observation suggests that the thermal stress had been relaxed by crack generation. The fourth difference is the relative amplitudes of $|S_r - S_\theta|$. The differences between the observation and simulation were listed in Table IV. In the observation, the $|S_r - S_\theta|$ in the stress wave in $\langle 110 \rangle$

FIG. 8. (a) $|S_r - S_\theta|$ distributions at various times inside LiF calculated by thermoelastic simulation of $\Delta T_{\max} = 100$ K, $w_{\text{th}} = 2.0$ μm , and $l_z = 20$ μm . (b) Distributions of the direction of the principal strains at 2000 ps, 3000 ps, and 6000 ps. The relation between the direction and color is shown by the colored semicircle. (c) and (d) Plots of the principal strain at 3000 ps along $\langle 110 \rangle$ and $\langle 100 \rangle$, respectively.

($|\Delta S^{(p)}_{\langle 110 \rangle}|$) was about 2.5 times larger than that in $\langle 100 \rangle$ ($|\Delta S^{(p)}_{\langle 100 \rangle}|$), whereas $|\Delta S^{(p)}_{\langle 110 \rangle}|$ was about 2.0 times larger than $|\Delta S^{(p)}_{\langle 100 \rangle}|$ (Figs. 8(c) and 8(d)) in the simulation. In addition, the strain peak at the crack tip ($|\Delta S^{(s)}_{\langle 100 \rangle}|$) was 1.3 times larger than $|\Delta S^{(p)}_{\langle 100 \rangle}|$ in the observation (Fig. 7(d)), whereas $|\Delta S^{(s)}_{\langle 100 \rangle}|$ was about 1.1 times larger than $|\Delta S^{(p)}_{\langle 100 \rangle}|$ in the simulation (Fig. 8(d)). These differences suggest that the strains in $\langle 110 \rangle$ and at the crack tip should be enhanced by the crack formation.

3. Amplitude of principal strain and stress in LiF

Figure 9 shows the temporal evolution of the $|\Delta S^{(T)}_\alpha|$ and $|\Delta P^{(T)}_\alpha|$ at the peak in the stress waves. The strain amplitudes at the same time delays and same positions were more than 3 times larger than those in MgO. This difference in the strain amplitudes between LiF and MgO should be due to the difference in the thermal expansion coefficients, which is $3.3 \times 10^{-5} \text{ K}^{-1}$ in LiF, whereas $1.1 \times 10^{-5} \text{ K}^{-1}$ in MgO (Table I). In these graphs, the decay profiles of the simulated principal strains were drawn by solid and dotted lines. The simulated decay profiles (solid and dotted lines in Figs. 9(b)–9(d)) reproduced the temporal evolutions of the observed strains. By comparing the observation with the simulation in $|\Delta S^{(p)}_{\langle 100 \rangle}|$, we evaluated that the initial temperature change in the photoexcited region ($\Delta T_{\max}$) should be $\Delta T_{\max} = 2000$ K at $2 \mu\text{J}$ and $\Delta T_{\max} = 1400$ K at $1 \mu\text{J}$ to generate the observed $|\Delta S^{(p)}_{\langle 100 \rangle}|$. However, these values are underestimated, because the observed strain distribution was different from the simulated one due to the crack formation. One difference between

the observation and simulation is the enhancement of the strain around the $\langle 110 \rangle$ lines from the photoexcited region; the observed $|\Delta S^{(p)}_{\langle 110 \rangle}|/|\Delta S^{(p)}_{\langle 100 \rangle}|$ was about 2.5, which was larger than the simulated value, 2.0 (Table IV). Therefore, when $\Delta T_{\max}$ is estimated by the comparison of $|\Delta S^{(p)}_{\langle 110 \rangle}|$ between the observation and simulation (solid and dotted lines in Fig. 9(c)), we obtained $\Delta T_{\max} = 2500$ K at $2 \mu\text{J}$ and $\Delta T_{\max} = 1800$ K at $1 \mu\text{J}$, which were larger 1.25 times higher than those estimated by $|\Delta S^{(p)}_{\langle 100 \rangle}|$. Using these temperature changes ($\Delta T_{\max} = 2500$ K and 1800 K) and Eq. (9), the stresses at the photoexcited region are estimated to be 16 GPa for $2 \mu\text{J}$ and 11 GPa for $1 \mu\text{J}$. These stresses are comparable to those of MgO at the same pulse energies.

Another difference is the relative amplitudes between $|\Delta S^{(s)}_{\langle 100 \rangle}|$ and $|\Delta S^{(p)}_{\langle 100 \rangle}|$; the observed $|\Delta S^{(s)}_{\langle 100 \rangle}|/|\Delta S^{(p)}_{\langle 100 \rangle}|$ was about 1.35 in average between 2000 ps and 6000 ps, whereas the simulated one was about 1.1 in the same time range (Table IV). The difference in $|\Delta S^{(s)}_{\langle 100 \rangle}|$ between the observation and simulation should be due to the crack generation, because the stress tends to concentrate near the crack tip, which is known as “stress concentration.”⁸ Our observation showed that the stress near the crack tip was enhanced by a factor of 1.2.

D. Comparison between MgO and LiF

According to the time-resolved observations by a pump-probe transmission microscope, a single stress wave was observed both in MgO and LiF, and only the difference was that the crack generation observed in LiF and not in MgO. On the other hand, the time-resolved birefringence imaging showed the generation of two stress waves: the faster stress wave, i.e., a primary stress wave, was attributed to a quasi-longitudinal elastic wave and the slower one, a secondary stress wave, was to a quasi-transverse elastic wave. In addition, we found a lot of differences in the stress dynamics between MgO and LiF single crystals from the transient birefringence distributions. The differences between MgO and LiF were summarized as follows:

- The strain amplitudes in LiF (Fig. 9) were more than 3 times larger than those in MgO (Fig. 6) at the same pulse energy.
- The strained region around the photoexcited region in MgO was comparable to the simulated one (Figs. 4(e) and 5(a)), whereas that in LiF was much smaller than the simulated one (Figs. 7(e) and 8(a)).
- The birefringent region of the primary stress wave in MgO was clearly separated from that of the secondary stress wave (Figs. 4(a) and 4(b)), whereas the

TABLE IV. Ratios of $|\Delta S^{(s)}_{\langle 100 \rangle}|$ and $|\Delta S^{(p)}_{\langle 110 \rangle}|$ to $|\Delta S^{(p)}_{\langle 100 \rangle}|$ inside LiF by the observation and elastic simulation.

	$ \Delta S^{(s)}_{\langle 100 \rangle} / \Delta S^{(p)}_{\langle 100 \rangle} $		$ \Delta S^{(p)}_{\langle 110 \rangle} / \Delta S^{(p)}_{\langle 100 \rangle} $	
	1 μJ	2 μJ	1 μJ	2 μJ
Observation	1.34 (± 0.10)	1.36 (± 0.09)	2.42 (± 0.18)	2.50 (± 0.20)
Simulation	1.09 (± 0.04)		2.02 (± 0.02)

FIG. 9. (a) The positions for $|\Delta S^{(p)}_{\langle 110 \rangle}|$, $|\Delta S^{(p)}_{\langle 100 \rangle}|$, and $|\Delta S^{(s)}_{\langle 100 \rangle}|$ in LiF. (b)–(d) The differences of principal strains and stresses inside LiF plotted against the time delays. Solid line and dotted line in (b) are $|S_r - S_\theta|$ by the simulation of $\Delta T_{\max} = 1180$ K, $w_{\text{th}} = 2 \mu\text{m}$ and that of $\Delta T_{\max} = 880$ K and $w_{\text{th}} = 2 \mu\text{m}$, respectively, those in (c) are $|S_r - S_\theta|$ by the simulation of $\Delta T_{\max} = 1930$ K and that of $\Delta T_{\max} = 1320$ K, respectively, and those in (d) are $|S_r - S_\theta|$ by the simulation of $\Delta T_{\max} = 2200$ K and that of $\Delta T_{\max} = 1200$ K, respectively.

birefringence in LiF was distributed between the primary and secondary stress waves (Figs. 7(a) and 7(b)). The birefringent regions of the primary and secondary stress waves in LiF were separated from each other after the crack propagation stopped (6000 ps in Fig. 7(b)).

- (iv) The observed ratio of $|\Delta S^{(p)}_{\langle 110 \rangle}|$ to $|\Delta S^{(p)}_{\langle 100 \rangle}|$ in MgO was 20%–25% smaller than that by the simulation (Table III), whereas that in LiF was about 1.25 times larger than that of the simulated value (Table IV).
- (v) The ratio of $|S_r - S_\theta|$ in the secondary stress wave ($|\Delta S^{(s)}_{\langle 100 \rangle}|$) to that in the primary stress wave in $\langle 100 \rangle$ ($|\Delta S^{(p)}_{\langle 100 \rangle}|$) in MgO was nearly same as that of the simulation (0.81 both in the experiment and simulation), whereas the observed ratio in LiF was about 1.2 times larger than that of the simulation (Table III).
- (vi) In LiF, birefringent regions of a cross pattern appeared in the $\langle 110 \rangle$ directions from the photoexcited region at several ns after photoexcitation (Fig. 7(e)), although they were not observed in the simulation (Fig. 8(a)) and in MgO (Fig. 4(e)).

These differences can be interpreted based on the difference in properties between MgO and LiF and crack generation, which occurred only in LiF. The difference of (i) (larger strain amplitudes in LiF at the same energy) could be due to larger thermal expansion coefficient of LiF ($\beta = 3.3 \times 10^{-5}$), which is about 3 times larger than that of MgO ($\beta = 1.1 \times 10^{-5}$; Table I). On the other hand, the other differences [(ii)–(vi)] could be originated from the crack generation only in LiF, because these differences mean that the observed strain distributions inside MgO could be reproduced by a linear elastic simulation, whereas the observed strain dynamics was different from the simulated ones inside a LiF except the velocities of the stress waves. The difference of (ii) should be due to the relaxation of the thermal stress around the photoexcited region due to the crack

generation inside LiF. The differences of (iii) and (iv) mean the enhancement of the strains in LiF. The larger strain in $\langle 110 \rangle$ inside LiF suggests that the crack generation inside LiF created free boundaries on the $\{100\}$ planes, which could facilitate the displacement from the $\{100\}$ surface of the cracks to the $\{110\}$ planes. The difference of (v) could be due to the concentration of strains near the crack tip inside LiF.⁸ The difference of (vi) suggests that the birefringent regions in the $\langle 110 \rangle$ directions from the photoexcited region inside LiF could be originated from dislocations, because the slip plane and direction in rock-salt crystals are of $\{110\}$ and $\langle 110 \rangle$, respectively, and strain field is generated around a dislocation.¹ The slow axes of the birefringent regions, which were parallel to the radial directions ($\langle 110 \rangle$), indicate that compression occurred in the radial directions in the birefringent region. Therefore, the dislocations could be generated by the compression in the $\langle 110 \rangle$ directions by thermal expansion in the photoexcited region and crack generation.

From the time-resolved strain observation, we found that the strain distribution became different from the simulation due to crack generation inside LiF. Then, why are cracks generated more easily by fs laser irradiation inside LiF than inside MgO? First, the reason was discussed in terms of differences in the elastic energy due to thermal expansion and surface energy. Initialization of crack propagation by photoexcitation should be related to the elastic energy by thermal expansion in the photoexcited region and surface energy that must be overcome to generate cracks.⁸ The elastic energy density, E_{elast} , can be expressed roughly by

$$E_{\text{elast}} \sim \frac{1}{2} k \varepsilon^2, \quad (14)$$

where k is the elastic constant and ε is the strain. According to Table I, thermal expansion coefficient of LiF is about 3 times larger than that of MgO, which results in 3.0 times

larger strain in LiF than in MgO ($\epsilon_{\text{LiF}} \sim 3 \times \epsilon_{\text{MgO}}$) under the same temperature change in a photoexcited region. Because the elastic constants of LiF are about 3 times smaller than those of MgO in average ($k_{\text{LiF}} \sim k_{\text{MgO}}/3$), the elastic energy due to thermal expansion in LiF should be 3 times larger than that of MgO. In addition, the surface energy of LiF is 3.5 times smaller than that of MgO. Therefore, comparison of elastic and surface energies suggests that larger temperature change is necessary to initiate crack generation in MgO than in LiF.

As another reason that cracks are generated more easily in LiF, we focused the difference in Poisson's ratios between LiF and MgO. Poisson ratio is defined as the ratio of lateral expansion to longitudinal contraction by application of compressive stress.²² According to the paper by Dr. Ballato,³⁵ the Poisson's ratio of a cubic crystal in the crack propagation direction ($\langle 100 \rangle$) is given by

$$\nu_{12} = C_{23}/(C_{11} + C_{23}). \quad (15)$$

Using C_{ij} s in Table I, the Poisson ratio of MgO is $\nu_{12(\text{MgO})} = 0.24$, while that of LiF is $\nu_{12(\text{LiF})} = 0.27$. Because the thermal expansion in the crack propagation direction induces tensile strain perpendicular to the crack by the factor of the Poisson ratio, the difference in the Poisson's ratio between LiF and MgO means that the strain to induce crack initialization in LiF is slightly larger (about 1.1 times $= \nu_{12(\text{LiF})}/\nu_{12(\text{MgO})}$) than that in MgO. Therefore, the differences in thermal expansion coefficient, surface energy, and elastic tensor between LiF and MgO should determine whether cleavage cracks are generated by fs laser irradiation.

IV. CONCLUSION

In conclusion, we observed the strain dynamics of fs laser-induced stress wave and deformation inside LiF and MgO single crystals by a pump-probe polarization microscope. The observed strain dynamics showed that the strain distributions were different with and without generation of cracks. Inside a MgO single crystal, in which cracks were not generated, the observed strain dynamics could be reproduced by the simulated strain dynamics after thermal expansion in the photoexcited region, whereas inside a LiF single crystal, the strain distributions during crack propagation were completely different from the simulated ones. In particular, the strain was distributed from cracks to the $\langle 110 \rangle$ regions of a stress wave and the strain in the $\langle 110 \rangle$ region was enhanced. Because this study is the first time that the amplitude and distribution of strain during crack propagation in a nanosecond time-range are elucidated to our knowledge, the observed strain dynamics could be an important clue to elucidate the mechanism of shock-induced modifications inside crystals.

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